COMPLIANT





N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)				
	0.015 at V _{GS} = 4.5 V	12					
20	0.017 at V _{GS} = 2.5 V	12	21 nC				
	0.021 at V _{GS} = 1.8 V	12					

PowerPAK ChipFET Single **Bottom View**

Ordering Information:

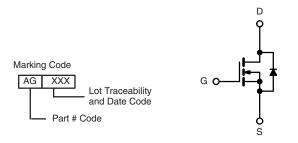
Si5486DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- TrenchFET® Power MOSFET
- New Thermally Enhanced PowerPAK® ChipFET® Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Load Switch, PA Switch, and for Portable Applications
- Point-of-Load



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless oth	erwise noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	20	V	
Gate-Source Voltage		V_{GS}	± 8	1 V	
	T _C = 25 °C		12 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1 .	12 ^a		
Continuous Diain Current (1) = 150 C)	T _A = 25 °C	I _D	11.6 ^{b, c}	Α	
	T _A = 70 °C	1	9.3 ^{b, c}		
Pulsed Drain Current		I _{DM}	40	1	
Continuous Source-Drain Diode Current	T _C = 25 °C		12 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	l _S	2.6 ^{b, c}		
	T _C = 25 °C		31	w	
Maximum Power Dissipation	T _C = 70 °C	P _D	20		
Maximum Power Dissipation	T _A = 25 °C	'D	3.1 ^{b, c}		
	T _A = 70 °C	1	2 ^{b, c}		
Operating Junction and Storage Temperatur	e Range	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temper	ature) ^{d, e}		260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	34	40	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3	4	O/ VV		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.

Document Number: 73783 S13-0194-Rev. C, 28-Jan-13



SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static	_			T	1			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		21		mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	ι _D = 230 μ/		- 3.4				
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4		1	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA		
Zara Cata Valtaga Drain Current	1	V _{DS} = 20 V, V _{GS} = 0 V			1	μΑ		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	40			Α		
		$V_{GS} = 4.5 \text{ V}, I_D = 7.7 \text{ A}$		0.012	0.015	+		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 7.3 \text{ A}$		0.014	0.017	Ω		
	_ = 5(5)	V _{GS} = 1.8 V, I _D = 4.8 A		0.017	0.021	1		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 7.7 \text{ A}$		46		S		
Dynamic ^b	0.0	20 2		<u> </u>				
Input Capacitance	C _{iss}			2100				
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		310		pF		
Reverse Transfer Capacitance	C _{rss}	56 7 de 7		180				
Tieverse transier dapacitatiee	9188	V _{DS} = 10 V, V _{GS} = 8 V, I _D = 9.3 A		36	54			
Total Gate Charge	Q_g	103 10 1, 103 1 1, 10 110 1		21	32	nC		
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 9.3 \text{ A}$		3.3				
Gate-Drain Charge	Q _{gd}	VDS = 10 V, VGS = 4.5 V, ID = 9.5 A		3.1				
Gate Resistance	R _g	f = 1 MHz		5		Ω		
Turn-on Delay Time	t _{d(on)}			10	15			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 1.1 \Omega$		15	25	ns		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9.3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		50	75			
Fall Time	t _f	ŭ		15	25			
Turn-On Delay Time				7	15			
Rise Time	t _{d(on)}	$V_{DD} = 10 \text{ V}, R_{L} = 1.1 \Omega$						
	t _r	$I_D \cong 9.3 \text{ A}, V_{GEN} = 10 \text{ V}, R_a = 1 \Omega$		15	25			
Turn-Off Delay Time	t _{d(off)}	D AGEN A		55	85			
Fall Time	t _f			10	15			
Drain-Source Body Diode Characteristi	· .	T 05 °C		T	10			
Continuous Source-Drain Diode Current	IS	T _C = 25 °C			12	Α		
Pulse Diode Forward Current	I _{SM}	1 01 4 1/ 01/		6.0	40	L .,		
Body Diode Voltage	V _{SD}	I _S = 9.1 A, V _{GS} = 0 V		0.8	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			30	60	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	$I_F = 9.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		17	30	nC		
Reverse Recovery Fall Time	t _a			12		ns		
Reverse Recovery Rise Time	t _b			18				

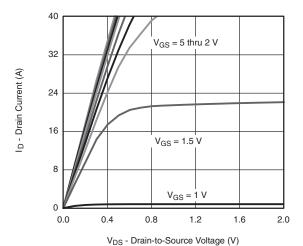
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

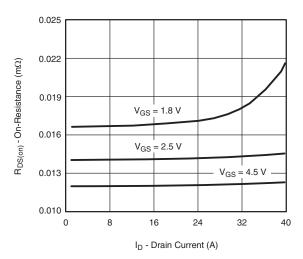
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.



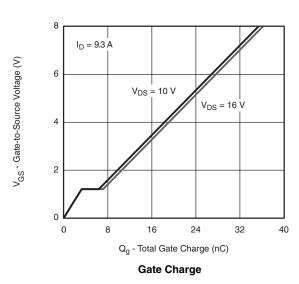
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

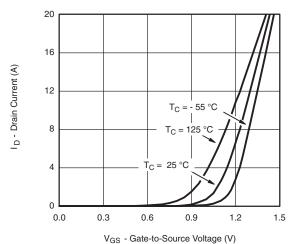


Output Characteristics

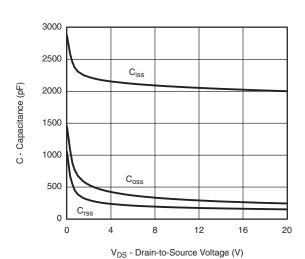


On-Resistance vs. Drain Current and Gate Voltage

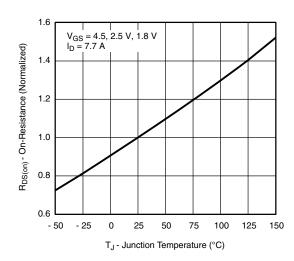




Transfer Characteristics

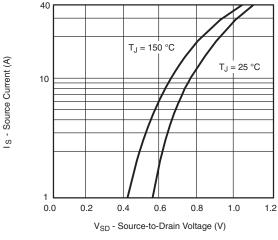


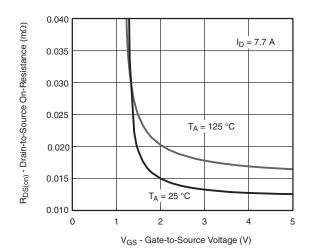
Capacitance



On-Resistance vs. Junction Temperature

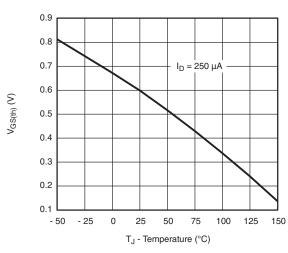
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

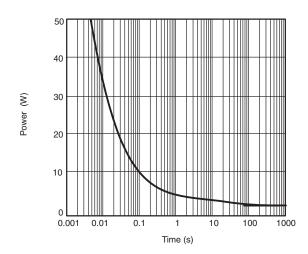




Source-Drain Diode Forward Voltage

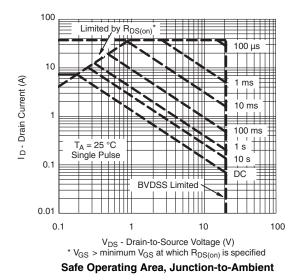
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

Single Pulse Power, Junction-to-Ambient



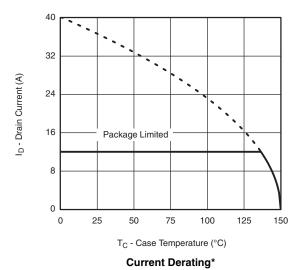


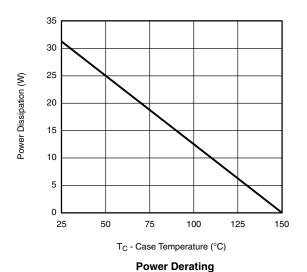




limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

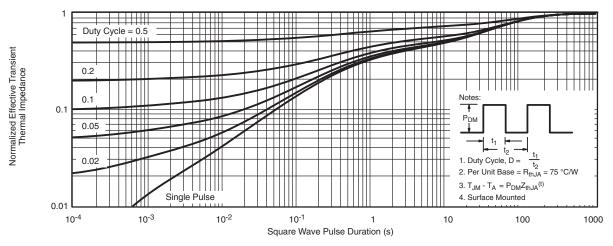




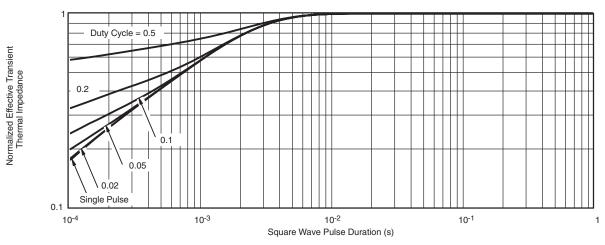
^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

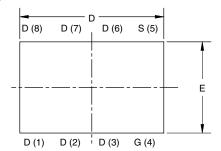


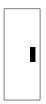
Normalized Thermal Transient Impedance, Junction-to-Case

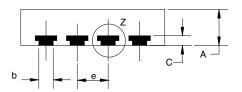
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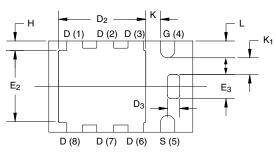


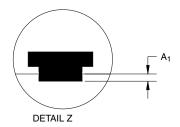
PowerPAK® ChipFET® SINGLE PAD











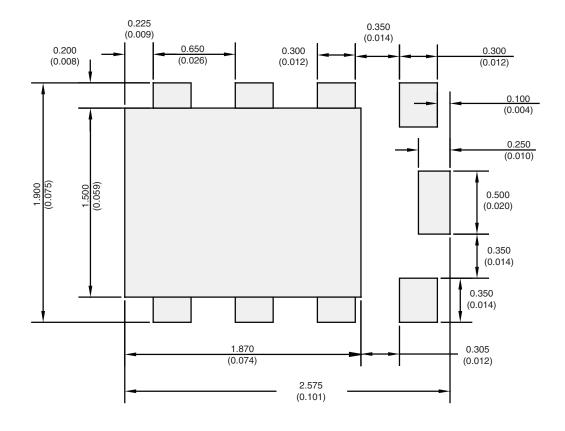
Backside view of single pad

	MILLIMETERS			INCHES				
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.85	0.028	0.030	0.033		
A ₁	0	-	0.05	0	-	0.002		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D	2.92	3.00	3.08	0.115	0.118	0.121		
D ₂	1.75	1.87	2.00	0.069	0.074	0.079		
D ₃	0.20	0.25	0.30	0.008	0.010	0.012		
E	1.82	1.90	1.98	0.072	0.075	0.078		
E ₂	1.38	1.50	1.63	0.054	0.059	0.064		
E ₃	0.45	0.50	0.55	0.018	0.020	0.022		
е		0.65 BSC			0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010		
K	0.25	-	-	0.010	-	-		
K ₁	0.30	-	-	0.012	-	-		
L	0.30	0.35	0.40	0.012	0.014	0.016		

Document Number: 73203 www.vishay.com 19-Jul-10



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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Revision: 02-Oct-12 Document Number: 91000